

Search Notes

Application/Control No.

10/667,249

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	149	7/11/2005 (04/11/06)	NKV
375	296	7/11/2005 (04/11/06)	NKV
375	297	7/11/2005 (04/11/06)	NKV
455	126	7/11/2005 (04/11/06)	NKV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See Search History Printout		04/11/06	NKV

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	04/11/06	NKV